

**Notice of References Cited**

Application/Control No.

10/643,166

Applicant(s)/Patent Under  
Reexamination  
KIM ET AL.

Examiner

Linh T. Nguyen

Art Unit

2627

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0110067	08-2002	Kondo et al.	369/47.54
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**NON-PATENT DOCUMENTS**

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